

Notice of References Cited	Application/Control No. 10/585,415		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner TAN TRINH		Art Unit 2618	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0207694	11-2003	Legare et al.	455/511
*	B	US-6,546,101	04-2003	Murray et al.	379/433.02
*	C	US-6,745,014	06-2004	Seibert et al.	455/74.1
*	D	US-2007/0127742	06-2007	Seven, Kazim	381/111
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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